

Notice of References Cited	Application/Control No. 10/605,163	Applicant(s)/Patent Under Reexamination WANG, SUNG-FEI	
	Examiner Alexander O Williams	Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,369,444 B1	04-2002	Degani et al.	257/724
	B	US-5,646,828	07-1997	Degani et al.	361/715
	C	US-6,483,186 B1	11-2002	Hsieh et al.	257/707
	D	US-6,304,451 B1	10-2001	Rife, William B.	361/704
	E	US-6,144,507	11-2000	Hashimoto, Nobuaki	359/819
	F	US-6,297,551 B1	10-2001	Dudderar et al.	257/723
	G	US-6,507,115 B2	01-2003	Hofstee et al.	257/777
	H	US-6,768,208 B2	07-2004	Lin et al.	257/777
	I	US-6,693,362 B2	02-2004	Seyama et al.	257/777
	J	US-5,977,640	11-1999	Bertin et al.	257/777
	K	US-6,734,539 B2	05-2004	Degani et al.	257/686
	L	US-2004/0042185 A1	03-2004	Kung et al.	361/760
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	3-187227A	08-1991	Japan	Osedo	
	O	2001-352021	12-2001	Japan	Kobayahi	
	P	1189280 A1	03-2002	Europe	Shibata et al.	
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.